

RoHS

# N-Channel 700V (D-S) Super Junction Power MOSFET

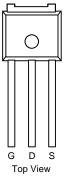
PRODUCT SUMMARY				
V <sub>DS</sub> (V) at T <sub>J</sub> max.	700			
R <sub>DS(on)</sub> at 25 °C (Ω)	$V_{GS} = 10 V$	0.5		
Q <sub>g</sub> max. (nC)	38			
Q <sub>gs</sub> (nC)	4			
Q <sub>gd</sub> (nC)	4.2			
Configuration	Single			

#### **FEATURES**

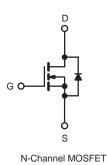
- Low figure-of-merit (FOM) Ron x Qa
- Low input capacitance (Ciss)
- Reduced switching and conduction losses
- Ultra low gate charge (Q<sub>q</sub>)
- Avalanche energy rated (UIS)

#### **APPLICATIONS**

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
  - High-intensity discharge (HID)
  - Fluorescent ballast lighting
- Industrial



TO-251



<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>C</sub> = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V <sub>DS</sub>	700	V	
Gate-Source Voltage			V <sub>GS</sub>	± 30	v	
Continuous Drain Current (T <sub>.1</sub> = 150 °C)	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C T <sub>C</sub> = 100 °C	- I <sub>D</sub> -	10		
Continuous Drain Current (1) = 150°C)	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 100 °C		9	A	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	30		
Linear Derating Factor				1.67/1.5/0.3	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	132	mJ	
Maximum Power Dissipation			PD	83/83/31	W	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C	
Drain-Source Voltage Slope	T <sub>J</sub> = 125 °C		dV/dt	50	V/ns	
Reverse Diode dV/dt <sup>d</sup>			uv/dt	3.1	v/ns	
Soldering Recommendations (Peak Temperature) <sup>c</sup> for 10 s			300	°C		

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature. b.  $V_{DD} = 50$  V, starting T<sub>J</sub> = 25 °C, L = 28.2 mH, R<sub>g</sub> = 25  $\Omega$ , I<sub>AS</sub> = 4.5 A.

c. 1.6 mm from case.

d.  $I_{SD} \leq I_D$ , dI/dt = 100 A/µs, starting  $T_J$  = 25 °C.



THERMAL RESISTANCE RATII	NGS							
PARAMETER	SYMBOL	TYP.		MAX.		UNIT		
Maximum Junction-to-Ambient	R <sub>thJA</sub>	- 80 - 0.6			00.001			
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>							
<b>SPECIFICATIONS</b> ( $T_J = 25 \ ^{\circ}C$ , u	nless otherwi	se noted)						
PARAMETER	SYMBOL	TES	T CONDIT	IONS	MIN.	TYP.	MAX.	UNIT
Static		•			•	•	•	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> =	= 0 V, I <sub>D</sub> =	250 µA	700	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C,	, I <sub>D</sub> = 1 mA	-	0.65	-	V/°C
Gate-Source Threshold Voltage (N)	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> =	250 µA	2	-	4	V
	_	,	$V_{GS} = \pm 20$	) V	-	-	± 100	nA
Gate-Source Leakage	I <sub>GSS</sub>		V <sub>GS</sub> = ± 30	) V	-	-	± 1	μA
		V <sub>DS</sub> =	= 650 V, V <sub>0</sub>	<sub>as</sub> = 0 V	-	-	1	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	_	$V_{DS} = 520 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 125 \text{ °C}$		-	-	10	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V		I <sub>D</sub> = 5 A	-	0.5	-	Ω
Forward Transconductance	<b>g</b> <sub>fs</sub>	V <sub>DS</sub>	= 30 V, I <sub>D</sub>	= 5 A	-	16	-	S
Dynamic		•						
Input Capacitance	C <sub>iss</sub>		$V_{GS} = 0$	/	-	680	-	
Output Capacitance	Coss	$V_{GS} = 0 V,$ $V_{DS} = 100 V,$ f = 1 MHz		-	140	-	pF	
Reverse Transfer Capacitance	C <sub>rss</sub>			-	5	-		
Effective Output Capacitance, Energy Related <sup>a</sup>	C <sub>o(er)</sub>	$V_{DS} = 0 V$ to 520 V, $V_{GS} = 0 V$		-	63	-		
Effective Output Capacitance, Time Related <sup>b</sup>	C <sub>o(tr)</sub>			-	113	-		
Total Gate Charge	Qg			-	38	56		
Gate-Source Charge	Q <sub>gs</sub>	$V_{GS} = 10 V$	$V_{GS} = 10 \text{ V}$ $I_D = 5 \text{ A}, V_{DS} = 520 \text{ V}$		-	4	-	nC
Gate-Drain Charge	Q <sub>gd</sub>				-	4.5	-	
Turn-On Delay Time	t <sub>d(on)</sub>				-	13	25	_
Rise Time	t <sub>r</sub>	$V_{DD} = 520 \text{ V}, \text{ I}_D = 5 \text{ A}, \\ V_{GS} = 10 \text{ V}, \text{ R}_g = 9.1 \ \Omega$		-	11	35	ns	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	81	90		
Fall Time	t <sub>f</sub>			-	25	40		
Gate Input Resistance	Rg	f = 1	MHz, ope	n drain	-	3.5	-	Ω
Drain-Source Body Diode Characteristic	S						1	
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	10	A	
Pulsed Diode Forward Current	I <sub>SM</sub>			-	-	30		
Diode Forward Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 5 A, V <sub>GS</sub> = 0 V		-	-	1.5	v	
Reverse Recovery Time	t <sub>rr</sub>	$T_{J} = 25 \text{ °C}, I_{F} = I_{S} = 5 \text{ A},$ dI/dt = 100 A/µs, V <sub>R</sub> = 400 V		-	270	-	ns	
Reverse Recovery Charge	Q <sub>rr</sub>			-	3.3	-	μC	
Reverse Recovery Current	I <sub>RRM</sub>			_	30	_	A	

#### Notes

a.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ . b.  $C_{oss(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ .



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

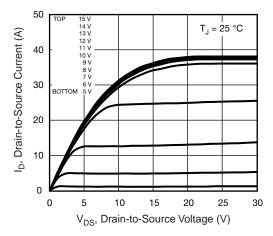


Fig. 1 - Typical Output Characteristics

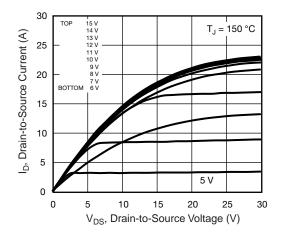


Fig. 2 - Typical Output Characteristics

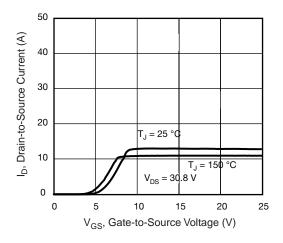


Fig. 3 - Typical Transfer Characteristics

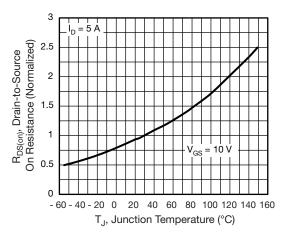


Fig. 4 - Normalized On-Resistance vs. Temperature

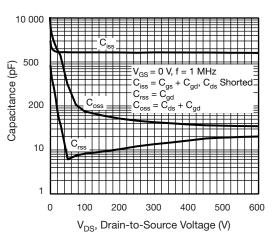


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

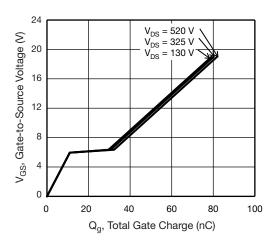


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

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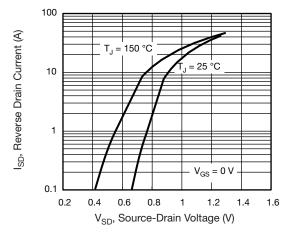
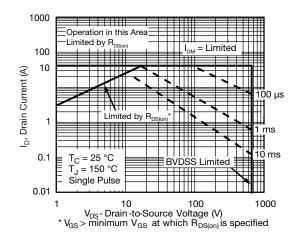


Fig. 7 - Typical Source-Drain Diode Forward Voltage





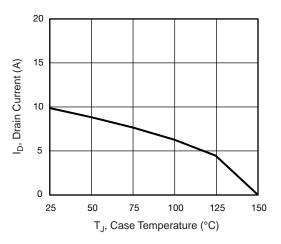


Fig. 9 - Maximum Drain Current vs. Case Temperature

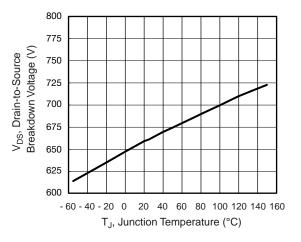


Fig. 10 - Temperature vs. Drain-to-Source Voltage

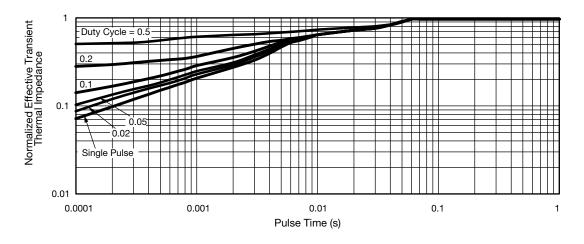


Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case



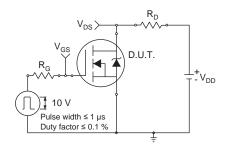


Fig. 12 - Switching Time Test Circuit

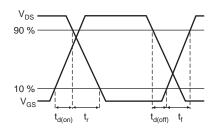


Fig. 13 - Switching Time Waveforms

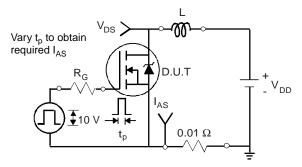


Fig. 14 - Unclamped Inductive Test Circuit

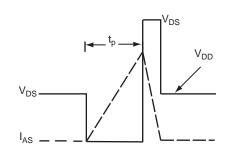


Fig. 15 - Unclamped Inductive Waveforms

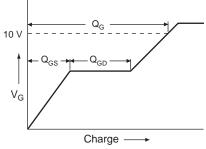


Fig. 16 - Basic Gate Charge Waveform

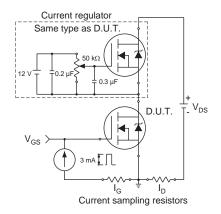
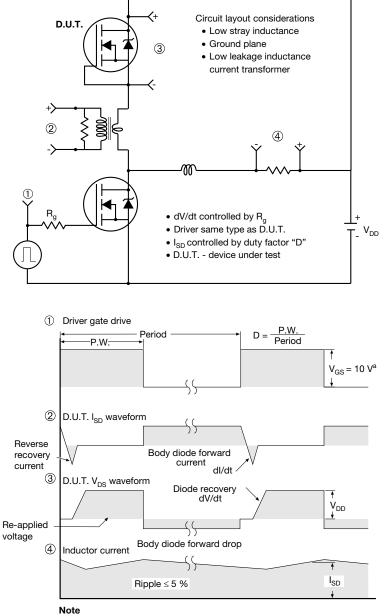


Fig. 17 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



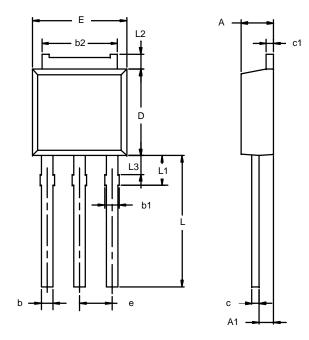
a.  $V_{GS} = 5$  V for logic level devices

Fig. 18 - For N-Channel

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### **TO-251AA**



	MILLIN	IETERS	INCHES		
Dim	Min	Max	Min	Max	
Α	2.21	2.38	0.087	0.094	
A1	0.89	1.14	0.035	0.045	
b	0.71	0.89	0.028	0.035	
b1	0.76	1.14	0.030	0.045	
b2	5.23	5.43	0.206	0.214	
С	0.46	0.58	0.018	0.023	
c1	0.46	0.58	0.018	0.023	
D	5.97	6.22	0.235	0.245	
Е	6.48	6.73	0.255	0.265	
е	2.28 BSC		0.090 BSC		
L	3.89	9.53	0.153	0.375	
L1	1.91	2.28	0.075	0.090	
L2	0.89	1.27	0.035	0.050	
L3	1.15	1.52	0.045	0.060	
ECN: S-03946—Rev. E, 09-Jul-01 DWG: 5346					

Note: Dimension L3 is for reference only.



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